Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/702,081	TAKANO ET AL.	
Examiner	Art Unit	
Mark A. Chapman	1756	

SEARCHED				
Class	Subclass	Date	Examiner	
430	111.1	10/31/2005	мс	
	111.4			
	108.1			
399	252			

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
430	111.1	10/31/2005	МС	
	111.4		-	
	108.1			

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
east	10/31/2005	МС
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